

<b>Notice of References Cited</b>	Application/Control No. 10/595,158	Applicant(s)/Patent Under Reexamination KIMURA, HAJIME	
	Examiner JENNIFER ZUBAJLO	Art Unit 2629	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,693,388	02-2004	Oomura, Masanobu	315/169.3
*	B	US-2005/0259054	11-2005	WU, JIE-FARN	345/082
*	C	US-2006/0001613	01-2006	Routley et al.	345/076
*	D	US-2005/0057580	03-2005	Yamano et al.	345/690
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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